Application/Control No. Applicant(s)/Patent Under Reexamination 10/602,033 SHIGETA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 XIAO M. WU 2674 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY * US-6,147,672 11-2000 Shimamoto, Hajime 345/589 Α * US-2002/0140662 10-2002 В Igarashi, Youichi 345/98 * 01-2003 US-2003/0016189 Abe et al. 345/55 С D US-US-Ε US-F US-G USн US-

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